



PRODUCT DATA SHEET



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Datasheet Resource

Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.



General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BVDSS	RDSON	ID
30V	4.5m $Ω$	64A

Features

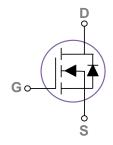
- 30V,64A, $RDS(ON) = 4.5m\Omega@VGS = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

Applications

- Networking
- Load Switch
- LED applications







Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	30	V
V _{GS}	Gate-Source Voltage	±20	V
1_	Drain Current – Continuous (T _C =25°C)	64	А
lD	Drain Current – Continuous (Tc=100°C)	40	Α
I _{DM}	Drain Current – Pulsed ¹	256	Α
EAS	Single Pulse Avalanche Energy ²	115	mJ
IAS	Single Pulse Avalanche Current ²	48	А
P _D	Power Dissipation (T _C =25°C)	44.6	W
FU	Power Dissipation – Derate above 25°C	0.36	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Symbol Parameter		Max.	Unit
RθJA	Thermal Resistance Junction to ambient		62	°C/W
Rejc	Thermal Resistance Junction to Case		2.8	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit
BV _{DSS}	BV _{DSS} Drain-Source Breakdown Voltage V _{GS} =0V , I _D =250uA		30			V
△BV _{DSS} /△T _J	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.03		V/°C
IDSS	Dunin Course Lookens Current	V _{DS} =30V , V _{GS} =0V , T _J =25°C			1	uA
	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =125°C			10	uA
I _{GSS}	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA

On Characteristics

R _{DS(ON)} Sta	Static Drain-Source On-Resistance	V _{GS} =10V , I _D =15A		3.6	4.5	mΩ
	Static Drain-Source On-Nesistance	V _{GS} =4.5V , I _D =10A		4.9	6.4	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA		1.6	2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			-4.17		mV/°C
gfs	Forward Transconductance	V _{DS} =10V , I _D =3A		10		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{3,4}		 34.6	70	
Qgs	Gate-Source Charge ^{3, 4}	V _{DS} =15V , V _{GS} =10V , I _D =15A	 5.5	11	nC
Q_{gd}	Gate-Drain Charge ^{3, 4}		 6.8	13	
T _{d(on)}	Turn-On Delay Time ^{3, 4}		 9.7	20	
Tr	Rise Time ^{3, 4}	V_{DD} =15 V , V_{GS} =10 V , R_{G} =3.3 Ω	 15.8	31	ne
T _{d(off)}	Turn-Off Delay Time ^{3, 4}	I _D =1A	 37.4	75	ns
Tf	Fall Time ^{3, 4}		 12	24	
Ciss	Input Capacitance		 1910	3800	
Coss	Output Capacitance V _{DS} =15V , V _{GS} =0V , F=1MHz		 300	600	pF
Crss	Reverse Transfer Capacitance		 230	460	
Rg	Gate resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	 1.14		Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	bol Parameter Conditions		Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V _G =V _D =0V . Force Current			64	Α
I _{SM}	Pulsed Source Current	VG=VD=UV, FOICE CUITEIN			128	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25°C			1	V

Note:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. V_{DD} =25V, V_{GS} =10V,L=0.1mH, I_{AS} =48A., R_{G} =25 Ω ,Starting T_{J} =25°C.
- 3. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 4. Essentially independent of operating temperature.



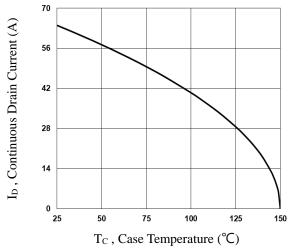


Fig.1 Continuous Drain Current vs. TC

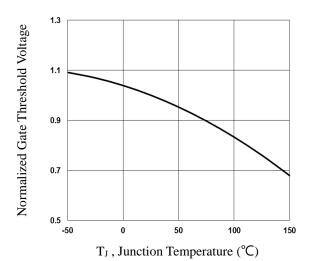


Fig.3 Normalized V_{th} vs. T_J

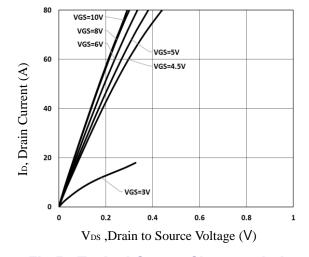


Fig.5 Typical Output Characteristics

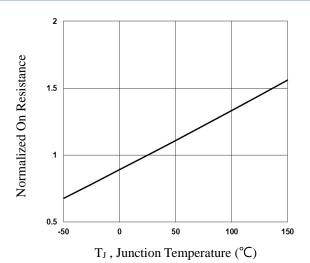


Fig.2 Normalized RDSON vs. TJ

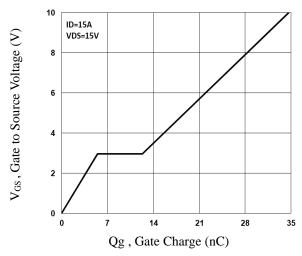


Fig.4 Gate Charge Characteristics

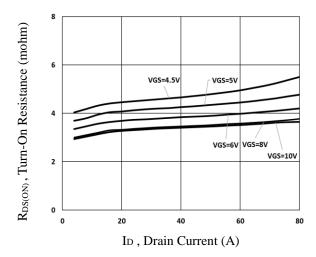


Fig.6 Turn-On Resistance vs. ID

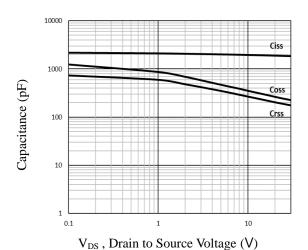


Fig.7 Capacitance Characteristics

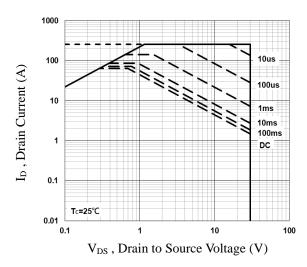


Fig.9 Maximum Safe Operation Area

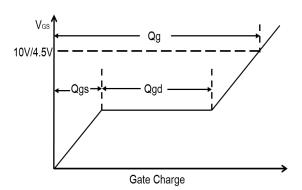


Fig.11 Gate Charge Waveform

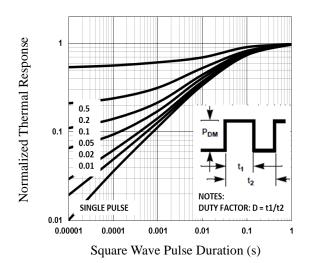


Fig.8 Normalized Transient Impedance

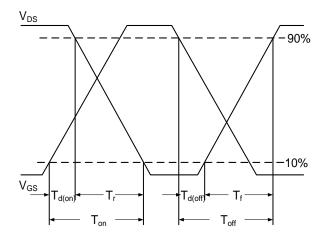
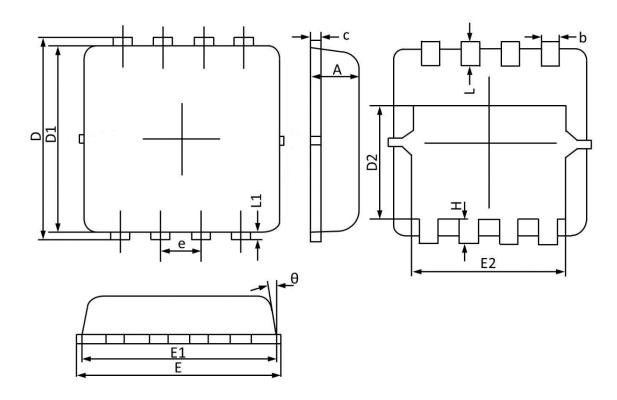


Fig.10 Switching Time Waveform



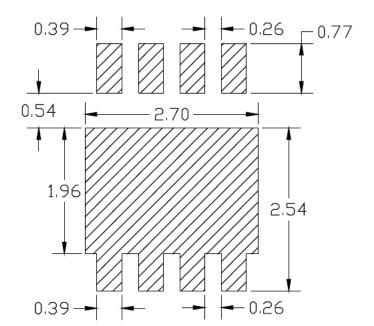
PPAK3x3 PACKAGE INFORMATION



Symbol	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	MAX	MIN	MAX	MIN
Α	0.900	0.700	0.035	0.028
b	0.350	0.250	0.014	0.010
С	0.250	0.100	0.010	0.004
D	3.500	3.050	0.138	0.120
D1	3.200	2.900	0.126	0.114
D2	1.950	1.350	0.077	0.053
E	3.400	3.000	0.134	0.118
E1	3.300	2.900	0.130	0.114
E2	2.600	2.350	0.102	0.093
е	0.65	BSC	0.02	6BSC
Н	0.750	0.300	0.030	0.012
L	0.600	0.300	0.024	0.012
L1	0.200	0.060	0.008	0.002
θ	14°	6°	14°	6°



PPAK3X3 RECOMMENDED LAND PATTERN



unit: mm



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